Notice of References Cited

Application/Control No. 10/604,620	Applicant(s)/Patent Under Reexamination CIACCI ET AL.	
Examiner	Art Unit	
Christopher Verdier	3745	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0017051 A1	01-2003	Coutandin et al.	416/97.00R
	В	US-4,214,852 A	07-1980	Tuley et al.	415/115
	С	US-6,709,231 B2	03-2004	Schipani et al.	415/160
	D	US-2004/0107538 A1	06-2004	Ciacci et al.	016/223
	Ę	US-2004/0109763 A1	06-2004	Ciacci et al.	416/097.00R
	F	US-6,682,297 B2	01-2004	Schipani et al.	415/115
	G	US-4,193,738 A	03-1980	Landis et al.	415/115
	Н	US-4,314,791 A	02-1982	Weiler	415/115
		US-4,529,357 A	07-1985	Holland	416/97R
	J	US-3,164,367 A	01-1965	LYNCH	416/97R
	К	US-3,066,910 A	12-1962	BLUCK	416/96R
	L	US-6,478,535 B1	11-2002	Chung et al.	415/115
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-55-117009-A	09-1980	Japan		416/96A
	0					
	Р					
	Q					
	R			·		
	S					
	T			<u>.</u>		

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.